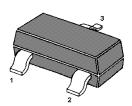
## N-Channel Enhancement Mode MOSFET

### Features

- AEC-Q101 Qualified
- Surface-mounted package
- Built-in G-S Protection Diode
- Halogen and Antimony Free(HAF), RoHS compliant
- Typical ESD Protection HBM Class 1C



1. Gate 2. Source 3. Drain SOT-23 Plastic Package

Classification	Voltage Range(V)				
0A	< 125				
0B	125 to < 250				
1A	250 to < 500				
1B	500 to < 1000				
1C	1000 to < 2000				
2	2000 to < 4000				
3A	4000 to < 8000				
3B	≥ 8000				

### Application

- Portable appliances
- Battery management

#### Parameter Symbol Value Unit 30 V **Drain-Source Voltage** VDS ± 20 V V<sub>GS</sub> Gate-Source Voltage **Continuous Drain Current** lь 100 mΑ Peak Drain Current, Pulsed <sup>1)</sup> lом 400 mΑ $\mathsf{P}_{\text{tot}}$ Total Power Dissipation<sup>2)</sup> 350 mW **Operating Junction and Storage Temperature Range** T<sub>J</sub>, T<sub>stg</sub> - 55 to + 150 °C

### Absolute Maximum Ratings (at Ta = 25°C unless otherwise specified)

#### **Thermal Characteristics**

Parameter	Symbol	Max.	Unit
Thermal Resistance from Junction to Ambient <sup>2)</sup>	R <sub>0JA</sub>	357	°C/W

<sup>1)</sup> Pw  $\leq$  10 µs, duty cycle  $\leq$  1%.

<sup>2)</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

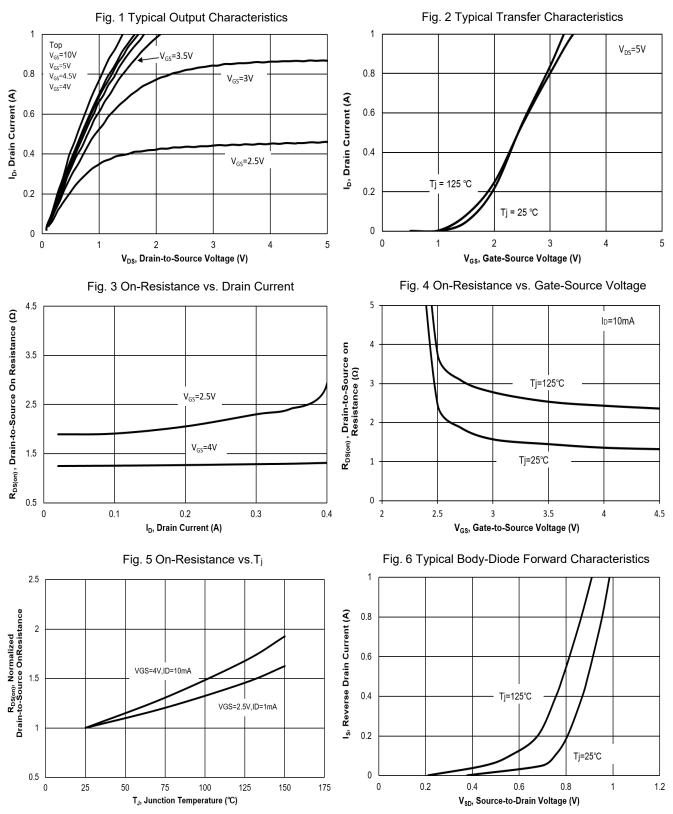


### Characteristics at $T_a = 25^{\circ}C$ unless otherwise specified

Parameter	Symbol	Min.	Тур.	Max.	Unit
STATIC PARAMETERS					
Drain-Source Breakdown Voltage at $I_D$ = 10 $\mu$ A	V <sub>(BR)DSS</sub>	30	-	-	V
Zero Gate Voltage Drain Current at V <sub>DS</sub> = 24 V	IDSS	-	-	1	μA
Gate-source Leakage at $V_{GS}$ = ± 20 V	lgss	-	-	± 1	μA
Gate Source Threshold Voltage at $V_{DS}$ = 3 V, $I_D$ = 100 $\mu$ A	$V_{GS(th)}$	0.8	-	1.5	V
Static Drain Source On-State Resistance at $V_{GS}$ = 4 V, $I_D$ = 10 mA at $V_{GS}$ = 2.5 V, $I_D$ = 1 mA	R <sub>DS(on)</sub>	-		8 13	Ω
DYNAMIC PARAMETERS					
Forward Transconductance at $V_{DS}$ = 10 V, $I_D$ = 0.2 A	<b>g</b> fs	-	0.71	-	S
Input Capacitance at $V_{GS}$ = 0 V, $V_{DS}$ = 25 V, f = 1 MHz	C <sub>iss</sub>	-	32	-	pF
Output Capacitance at $V_{GS}$ = 0 V, $V_{DS}$ = 25 V, f = 1 MHz	C <sub>oss</sub>	-	10.2	-	pF
Reverse Transfer Capacitance at $V_{GS}$ = 0 V, $V_{DS}$ = 25 V, f = 1 MHz	C <sub>rss</sub>	-	7.5	-	pF
Turn-On Delay Time at V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 30 V, R <sub>G</sub> = 25 $\Omega$ , I <sub>D</sub> = 0.4 A	t <sub>d(on)</sub>	-	5.4	-	ns
Turn-On Rise Time at V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 30 V, R <sub>G</sub> = 25 $\Omega$ , I <sub>D</sub> = 0.4 A	tr	-	2.7	-	ns
Turn-Off Delay Time at V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 30 V, R <sub>G</sub> = 25 $\Omega$ , I <sub>D</sub> = 0.4 A	$t_{d(off)}$	-	5.8	-	ns
Turn-Off Fall Time at V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 30 V, R <sub>G</sub> = 25 $\Omega$ , I <sub>D</sub> = 0.4 A	t <sub>f</sub>	-	30	-	ns
Body-Diode PARAMETERS	· · ·				
Drain-Source Diode Forward Voltage at $I_S = 115 \text{ mA}$	V <sub>SD</sub>	-	-	1.2	V
Body-Diode Continuous Current	ls	-	-	100	mA



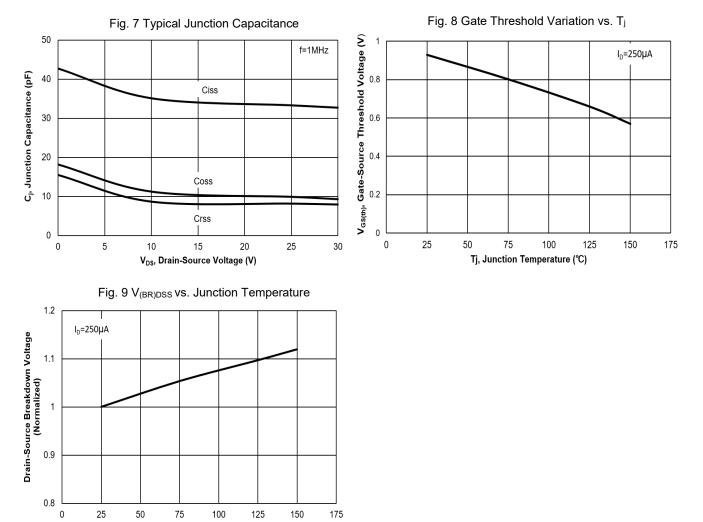
### **Electrical Characteristics Curves**





### **Electrical Characteristics Curves**

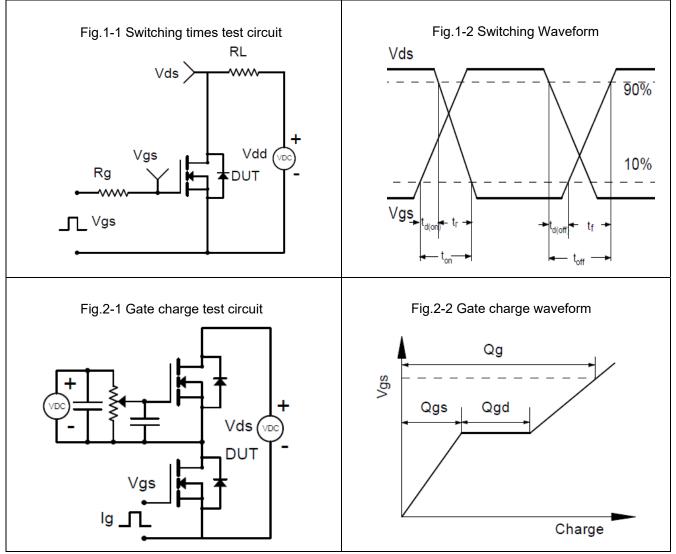
T<sub>J</sub>, Junction Temperature (°C)





# MMFTN3018K-AH

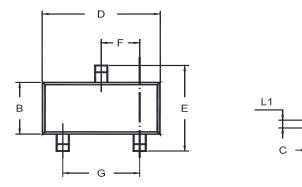
### **Test Circuits**





# MMFTN3018K-AH

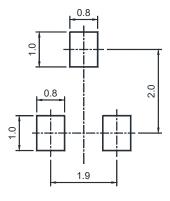
### Package Outline (Dimensions in mm)





Unit	А	A1	В	С	D	E	F	G	L	L1
mm	1.20	0.100	1.40	0.19	3.04	2.6	1.02	2.04	0.51	0.2
mm	0.89	0.013	1.20	0.08	2.80	2.2	0.89	1.78	0.37	MIN

### **Recommended Soldering Footprint**



### **Packing information**

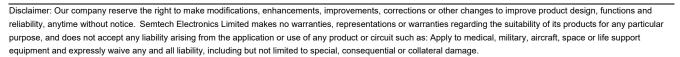
Package Tape Width (mm)		Pit	tch	Reel	Size	
		mm	inch	mm	inch	Per Reel Packing Quantity
SOT-23	8	4 ± 0.1	0.157 ± 0.004	178	7	3,000

N

. 1K

### **Marking information**

- " 1K " = Part No.
- " " = HAF (Halogen and Antimony Free)
- " YM " = Date Code Marking
- " Y " = Year
- " M " = Month
- Font type: Arial





### SOT-23